Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/586,601	ONO, SHUJI	
Examiner	Art Unit	
Nhan T. Tran	2622	

	SEARCHED  Subclass Date Examiner			
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated EAST search, used prieviously cited references	2/12/2007	NT	
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